

Application/Control No.	Applicant(s)/Patent under Reexamination
10/617,048	LIEW ET AL.
Examiner	Art Unit

Ana L. Woodward

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Class	Subclass	Date	Examiner
624	26/	7/07	A
	268		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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U.S. Patent and Trademark Office

Part of Paper No. 20070801

523 201,903,205, 206, 209, 212, 216

Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/617,048	LIEW ET AL.
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Ana L. Woodward	1711

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